

Search Notes

Application/Control No.

10/524,582

Examiner

Tan Ho

Applicant(s)/Patent under
Reexamination

IGUCHI ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	700NS	2/16/06	T.H.
↓	702	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR